


<b>Search Notes</b>  	<b>Application/Control No.</b>  10760131	<b>Applicant(s)/Patent Under Reexamination</b>  LARGMAN ET AL.
	<b>Examiner</b>  Revak, Christopher A	<b>Art Unit</b>  2131

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
none	none	7/23/07	CR

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
BRS Text Search: USPAT, US PGPUB, USOCR, DERWENT, FPRS, IBM TDB, EPO, JPO (see attached strategy)	7/23/07; 2/11/08	CR
DIALOG Text Search: COMPSCI, ELECTRON, SOFTWARE (see attached strategy)	7/23/07; 2/11/08	CR
Interference Search (see attached strategy)	2/11/08	CR

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
726	1,2,16,17,22,24,26,27	2/11/08	CR